# Concepts and Mechanisms of Dependable Systems

Summer Term 2009



Embedded Networks 09

J. Kaiser, IVS-EOS

Paulo Veríssimo, Luís Rodrigues: **Distributed Systems for System Architects** Kluwer Academic Publishers, Boston, January 2001

Eugen Schäfer: "Zuverlässigkeit, Verfügbarkeit und Sicherheit in der Elektronik, Eine Brücke von der Zuverlässigkeittheorie zu den Aufgaben der Zuverlässigkeitspraxis", 1. Auflage, Vogel Verlag, 1979, ISBN 3-0823-0586-8,

Karl-Erwin Großpietsch: "Zuverlässigkeitstheoretische Grundlagen", GMD-Seminar, St. Augustin

Stefan Poledna: "Lecture on Fault-Tolerant Systems", Vorlesungsfolien, Institut für Technische Informatik, TU Wien, SoSe 1996



## **Dependability**

#### **Dependability:**

The dependability of a system is its ability to deliver specified services to the end users so that they can justifiably rely on and trust the services provided by the system.

The function or service is the behaviour which can be observed at the interface to other systems which interact with the observed system. Quality referes to the conformance to the specifications.

Algirdas Avižienis, Jean-Claude Laprie, Brian Randell

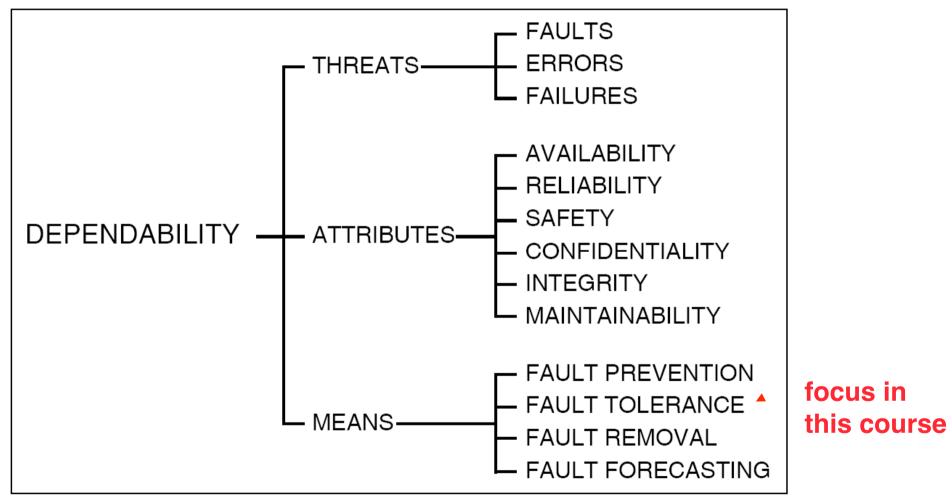
**Fundamental Concepts of Dependability** 

UCLA CSD Report no. 010028 LAAS Report no. 01-145 Newcastle University Report no. CS-TR-739



#### **Dependability Tree**

#### will be treated later





## **Attributes of Dependability**

Dependability has several attributes, including reliability, availability, maintainability, security (with aspects like privacy, confidentiality and integrity) and safety.

Availability: The availability of a system for a period (0,t) is the probability that the system is available for use at any random time in (0,t).

**Reliability:** The reliability of a system for a period (0,t) is the probability that the system is continuously operational (i.e., does not fail) in time interval (0,t) given that it is operational at time 0.

Maintainability: The maintainability of a system is a measure of the ability of the system to undergo maintenance or to return to normal operation after a failure.

**Safety:** The safety of a system for a period (0,t) is the probability that the system will not incur any catastrophic failures in time interval (0,t).



## **Mechanisms of Fault-Tolerance**

#### (Explizit) Fault-Treatment

**Dynamic Redundancy** 

**Error Detection** 

Damage Assessment and Confinement

Fault-Treatment

Þ.

Reconfiguration

Recovery

Fault-Masking

Static Redundancy

e.g. Error Correcting Codes

n-out-of - m - Majority Voting

All Mechanisms of Fault-Tolerance are based on Redundancy

- Information Redundancy
- Component Redundancy
- Time Redundancy



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How to determine reliability of composed systems?

Structure-based modelling:

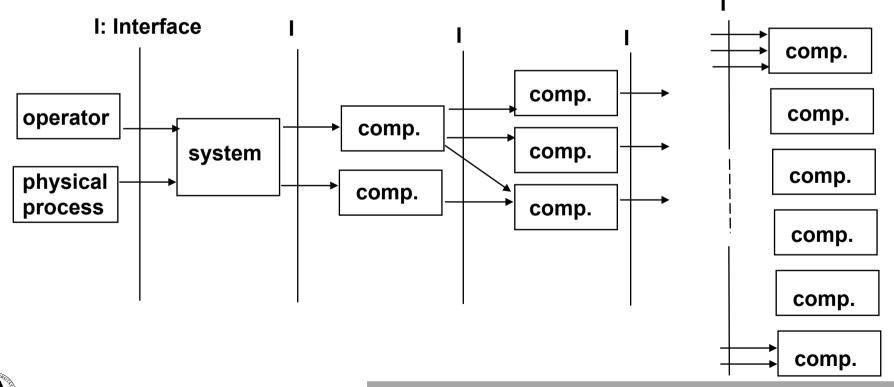
- identifiable independent components
- every component has an individual reliability
- the construction of the model is based on the connection structure



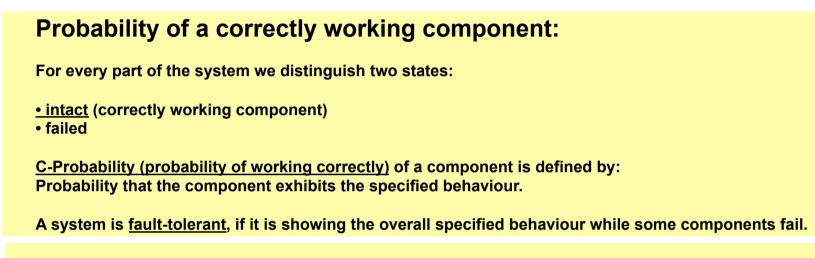
## How to determine reliability of composed systems?

- A System is defined by:
- its structure, i.e.the topology of its components
- its behaviour, i.e. by the overall behaviour of all of its components

systemcomponents are organized in a hierarchical way. This results in a dependency relation ( $\rightarrow$ ) between the system layers.

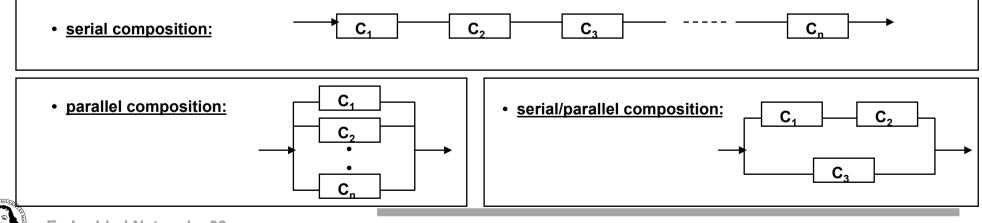


#### Determining reliability quantitatively by reliability diagrams

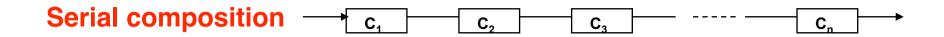


**Reliability Diagrams** (do not mix up with electrical schematics) :

Abstracting a system in components. Every component has a specified reliability.



## **Probability for a correctly working system:**



 $P_{series} = P(C_1 \text{ intact}) \text{ and } P(C_2 \text{ intact}) \text{ and } \dots P(C_n \text{ intact})$ 

Assumption: The properties ( $C_i$  intact) (i=1,..,n) are independent.

$$P_{\text{series}} = P(C_1 \text{ intact}) \bullet P(C_2 \text{ intact}) \bullet \dots \bullet P(C_n \text{ intact})$$

with p<sub>i</sub> : probability of unfailed component (C-probability):

$$\square P_{\text{series}} = p_1 \cdot p_2 \cdot \dots \cdot p_n$$

Examplel:

n identical Components:

 $\begin{array}{l} {{\sf P}_{{\rm series}}} \text{ for } {p_i}^n, \ n = 5, \, {p_i} = 0.99 \text{: } {{\sf P}_{{\rm series}}} = 0.99^5 = 0.95 \\ {{\sf P}_{{\rm series}}} \text{ for } {p_i}^n, \ n = 5, \, {p_i} = 0.70 \text{: } {{\sf P}_{{\rm series}}} = 0.70^5 = 0.16 \end{array}$ 

## **Probability for a correctly working system:**

#### parallel composition

Probability of failure (F-probability) = 1 - C-probability (correct and failed are complementary events).

$$P_{parallel} = P(C_1 \text{ failed}) \text{ and } P(C_2 \text{ failed}) \text{ and } \dots P(C_n \text{ failed})$$

Assumption: The properties (C<sub>i</sub> failed) (i=1,..,n) are independent..

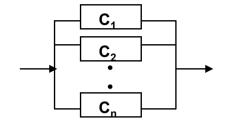
$$P_{\text{parallel}} = P(C_1 \text{ failed}) \cdot P(C_2 \text{ failed}) \cdot \dots \cdot P(C_n \text{ failed})$$

#### p<sub>i</sub> : F-probability of component i:

$$P_{\text{parallel}} = 1 - (p_1 \cdot p_2 \cdot \dots \cdot p_n)$$

Example F-probability:

n identical Components:



Systems of n components in which at least k components are working correctly.

Probability that exactly k defined components are correct (components 1,...,k), while the other n-k components failed (componenten k+1,...,n) is given by:

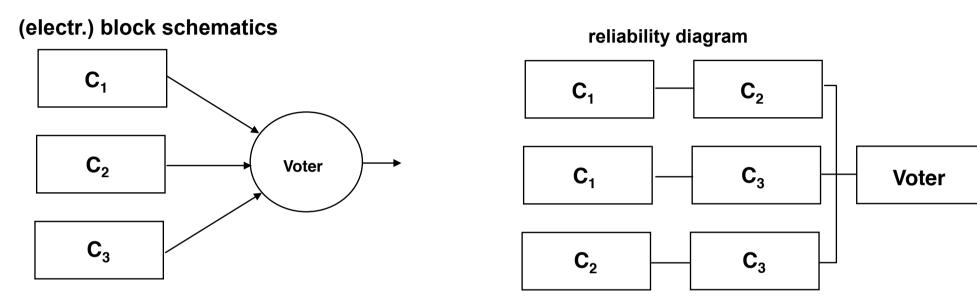
$$P_{k-aus-n} = p_1 \cdot p_2 \cdot \dots \cdot p_k \cdot (1 - p_{k+1}) \cdot (1 - p_{i+2}) \cdot \dots \cdot (1 - p_n)$$

There are  $\binom{n}{i}$  possibilities, to select i components out of n components:  $P_{k-out-of-n} = \sum_{i=k}^{n} \binom{n}{i} p^{i} \cdot (1-p)^{n-i}$ 

Example: 2-out-of-3 System:  $\begin{pmatrix} 3 \\ 2 \end{pmatrix} p^2 \cdot (1-p)^{3-2} + \begin{pmatrix} 3 \\ 3 \end{pmatrix} p^3 \cdot (1-p)^{3-3} = 3 \cdot p^2 \cdot (1-p) + p^3 \cdot 1$ 



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$$P_{TMR} = (p^3 + 3 p^2 \cdot (1 - p)) \cdot p_{voter}$$

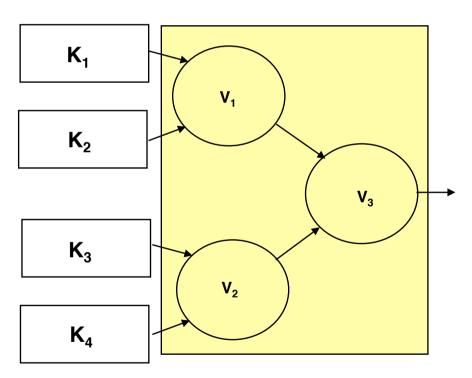
$$p = 0,9, p_{voter} = 0,99: P_{TMR} = (0,9^3 + 3 \cdot 0,9^2 \cdot (1 - 0,9)) \cdot 0,99$$

$$= (0,729 + 3 \cdot 0,81 \cdot (1 - 0,9)) \cdot 0,99$$

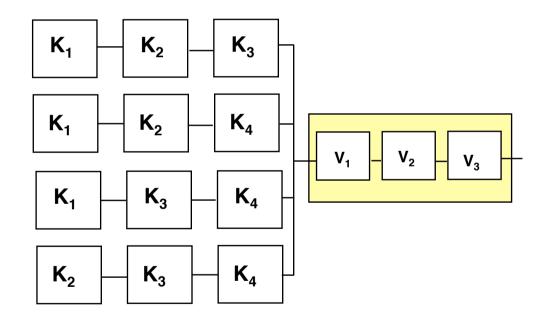
$$= (0,729 + 2,43 \cdot 0,1) \cdot 0,99 = 0,972 \cdot 0,99$$

$$= 0,96228$$

#### (electr.) block schematics



#### reliability diagram





$$P_{P\&S} = (p^{4} + 4 p^{3} \cdot (1 - p)) \cdot p_{voter}$$

$$p = 0,9, p_{voter} = 0,99: P_{P\&S} = (0,9^{4} + 4 \cdot 0,9^{3} \cdot (1 - 0,9)) \cdot 0,99$$

$$= (0,656 + 4 \cdot 0,73 \cdot (1 - 0,9)) \cdot 0,99 = 0,948 \cdot 0,99$$

$$= 0,9385$$

$$p = 0,9, p_{v1,2} = 0,99, p_{v3} = 0,999:$$

$$P_{P\&S} = (0,9^{4} + 4 \cdot 0,9^{3} \cdot (1 - 0,9)) \cdot 0,99^{2} \cdot 0,999$$

$$= (0,656 + 4 \cdot 0,73 \cdot (1 - 0,9)) \cdot 0,979$$
$$= (0,656 + 2,92 \cdot 0,1) \cdot 0,99 = 0,948 \cdot 0,9879$$

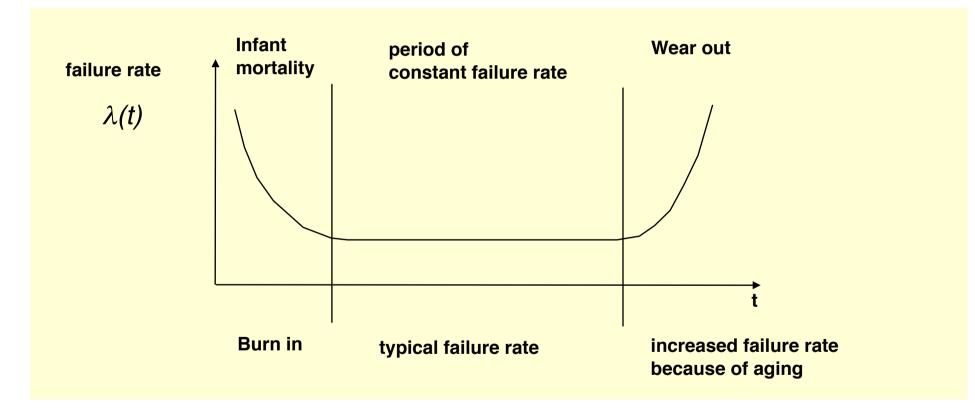
#### = 0,928



## How to derive the probability of component failure ?



#### The "bath tub" curve



#### Typical failure rates: VLSI-Chip: 10<sup>-8</sup> failures/h = 1 failure during 115000 years



Note:

The failure rate is defined relative to the number of correct components. In a certain time interval, if always the same number of components fail, the failure rate increases relatitively to the number of correct components that becomes smaller by every failed component.



#### **Dependability measures**

*Lifetime T* Time interval from the mission start to a non-repairable failure

Failure Rate  $\lambda$  (*t*) number of failures per time unit

**Probability of failure** F(t) probability to fail in the interval [0,T], T < t<sub>i</sub>.

**Reliability** R(t)Probability that a component did not fail until time  $t_i$ . F(t) is the complement to R(t).

R(t) = 1 - F(t)

for non repairable systems R(t) is a monotonely decreasing function. R(0)  $\leq$  1, R( $\infty$ ) = 0

#### **Probability density function** f(t)

 $f(t) = \frac{dF(t)}{dF(t)}$ 

dt

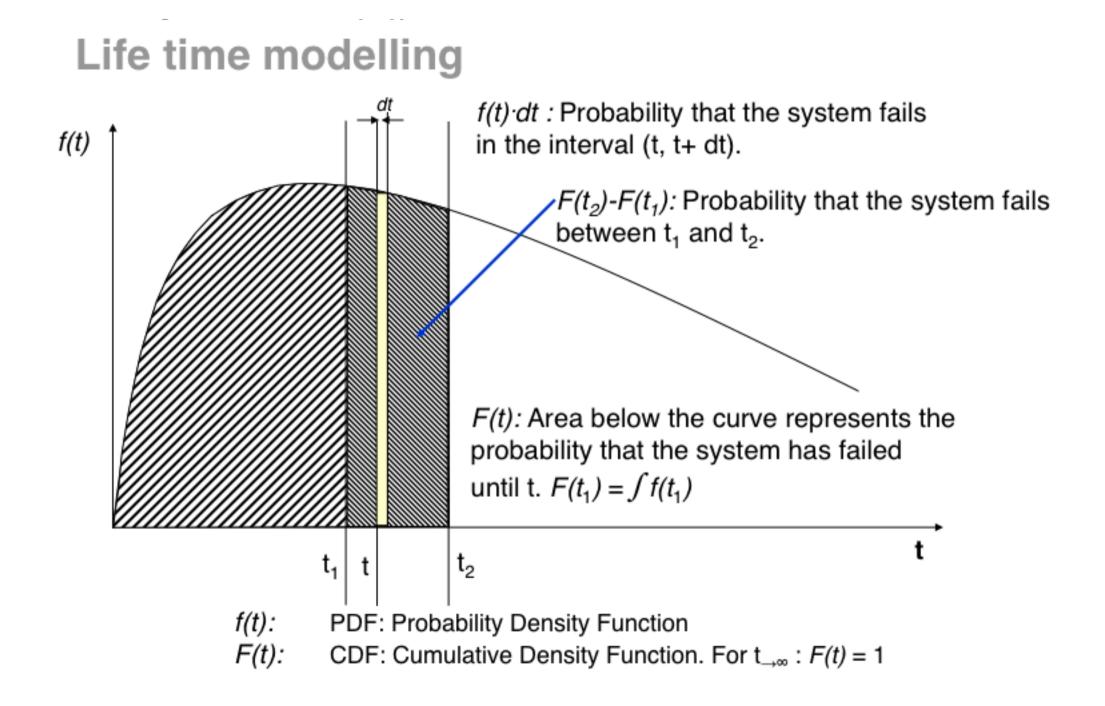
f(t) models how failures probabilities are distributed over time

f(t) • dt is the probability that a failure occurs in interval (t, t+dt))



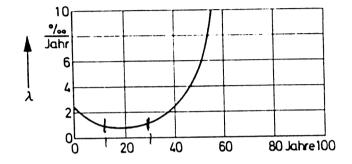
dR(t)

dt

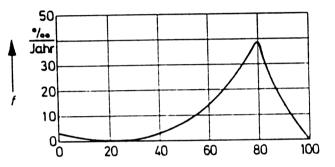


## **Probability distribution for human life**

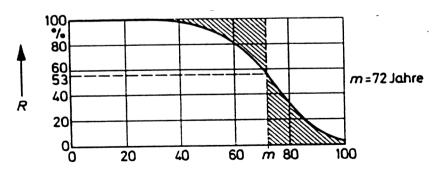
failure rate  $\lambda$  (t)



probability density f(t)



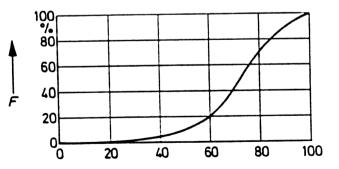
Reliability R(t)



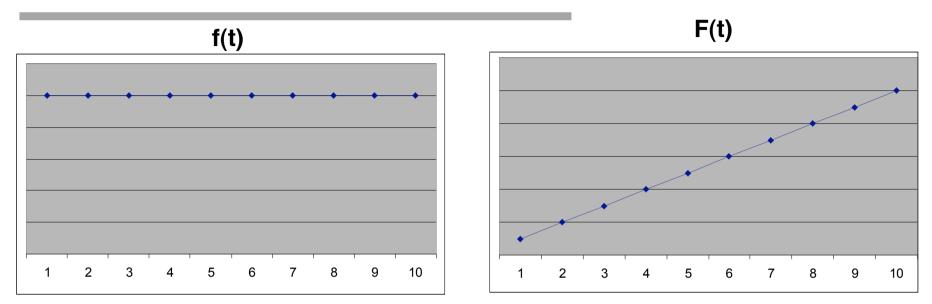


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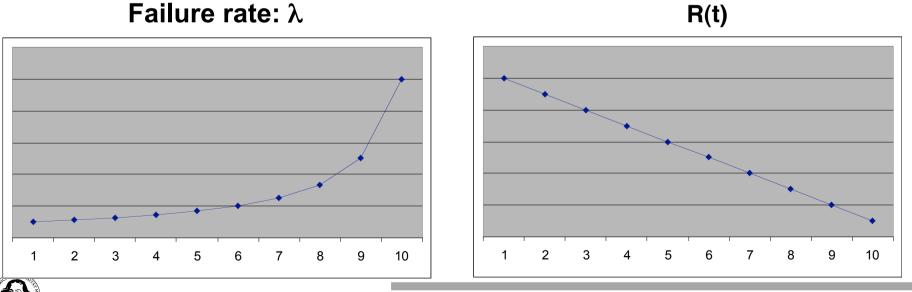
failure probablity F(t)



#### Behaviour under constant probability density



#### Failure rate: $\lambda$

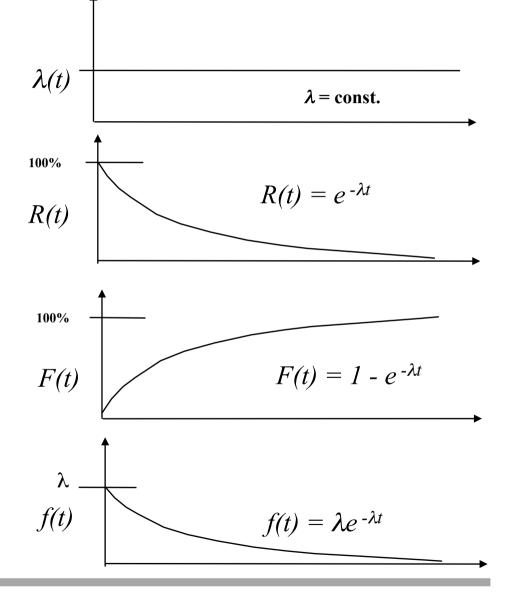


## **Dependability measures**

#### failure rate $\lambda$ (t) number of failures per hour

Remember: The failure rate is defined relative to the number of correct components. In a certain time interval, if always the same number of components fail, the failure rate increases relatitively to the number of correct components that becomes smaller by every failed component.

If the failure rate remains constant wrt. the set of correct components, this results in an exponential distribution for the reliability R(t).





Parameter	Symbol	Unit
life time	Т	h
failure probability	F	%
reliability	R	%
probability density	f	%/h
failure rate	λ	1/ <b>h</b>



Assuming 
$$\lambda$$
 (t) = const. we have:  
 $\frac{1}{\lambda}$  = MTBF = MTTFF = MTTF  
 $\lambda$ 

**MTBF : Mean Time Between Failures** 

**MTTFF: Mean Time To First Failure** 

**MTTF : Mean Time To Failure** 



## **Dependability measures**

#### Availability

time in which the system works correct related to the (down-) time when it is repaired.

A = U (Up time) M (Mission time)

M = U + TR (Repair time)

$$A = \frac{MTBF}{MTBF + MTTR}$$



## **Dependability measures**

#### **Availability Classes**

class: [log<sub>10</sub> (1/(1-A))]

1 year = 525600 minutes = 8760 h

system type	non-availability minutes/year	availability %	class
non-adminitrated systems	50 000	~ 90	1
administrated systems	5 000	99	2
well admin. syst.	500	99,9	3
fault-tolerant syst.	50	99,99	4
high availability syst.	5	99,999	5
very high avail. syst.	0,5	99,9999	6
ultra-high avail. syst.	0,05	99,99999	7



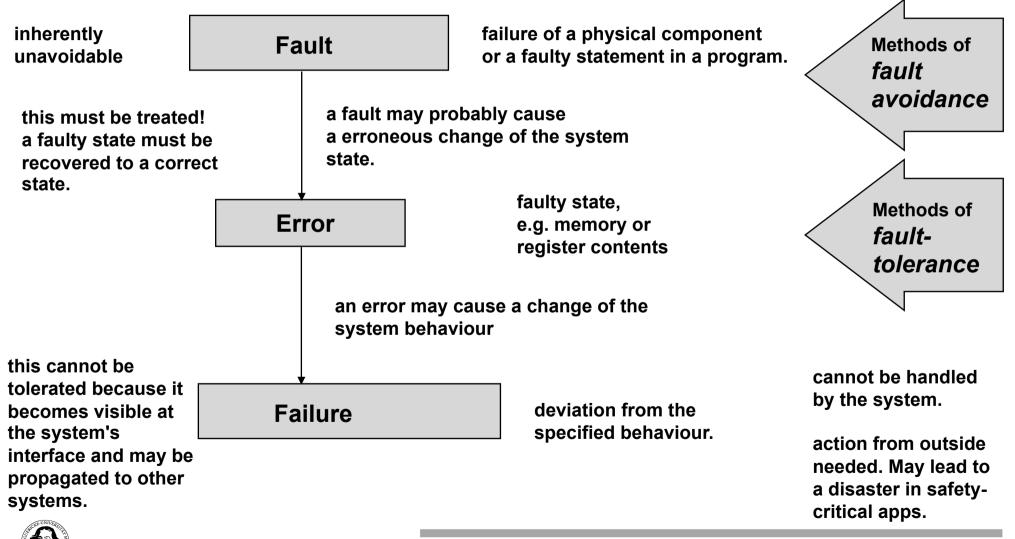
## Impairments:

## Faults, errors, failures

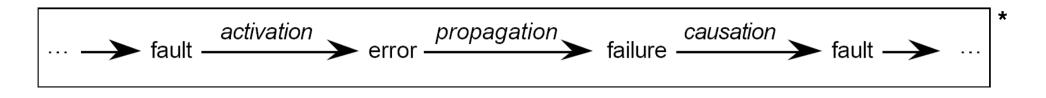


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## The Cause-Effect-Chain: Classifying Impairments



## The Cause-Effect-Chain: Classifying Impairments



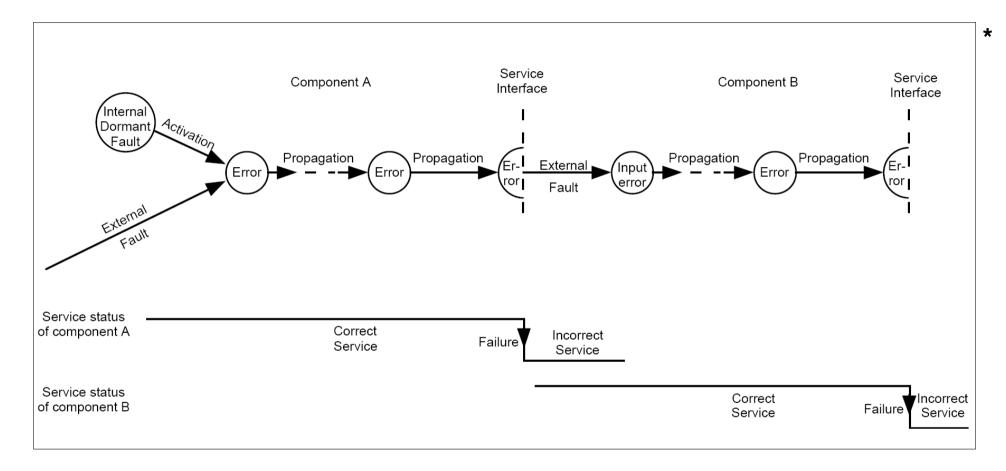
#### transitions:

- fault  $\rightarrow$  error: A fault which has not been activated by a computation is called *dormant*. A fault is *activated* if it causes an error.
- error→ failure: An error is *latent* if it has not yet lead to a failure or has been detected by some error detection mechanism. An error is *effective* if it caused a failure.
- failure→ fault: A fault is caused if the error becomes effective and the specified service is affected. This failure can be propagated and appears as a fault on a higher system layer or in a connected component.

\* Algirdas Avižienis, Jean-Claude Laprie, Brian Randell: Fundamental Concepts of Dependability



## The Cause-Effect-Chain: Classifying Impairments



#### **Error Propagation**

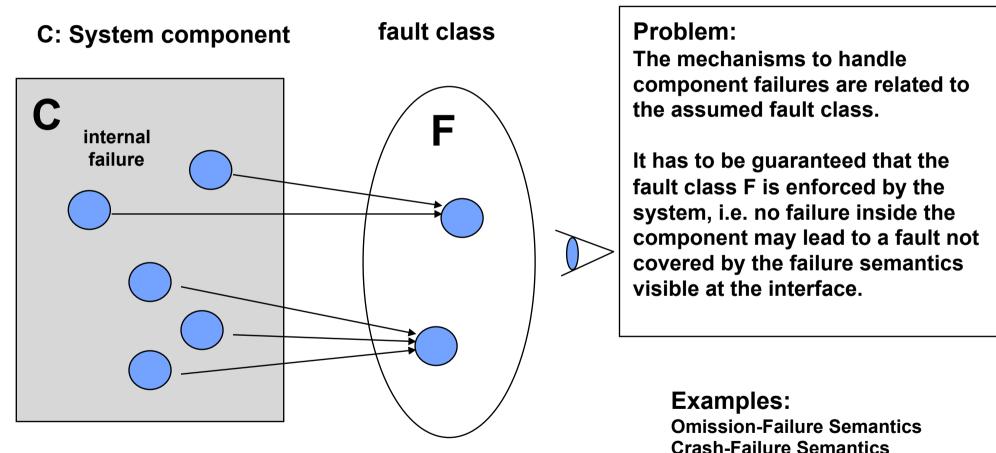
\* Algirdas Avižienis, Jean-Claude Laprie, Brian Randell: Fundamental Concepts of Dependability



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## **Abstracting Failures: Failure Semantics**

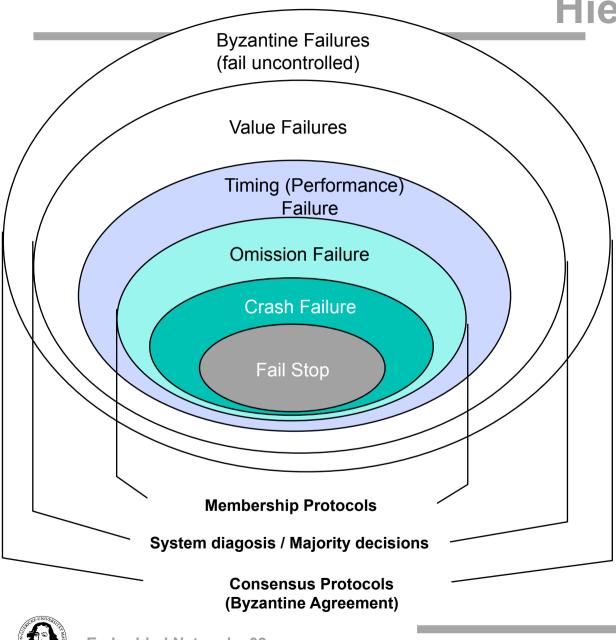
The fault semantics describes the assumptions about the effect of internal failures on the observable behaviour of a system component. It thus describes an abstraction of internal failures.



#### S has the failure semantics of F



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## **Hierarchy of Failures**

Byzantine Failure: Arbitrary, uncontrolled.

Timing (Prerformance) Failures Correct values but too early or too late.

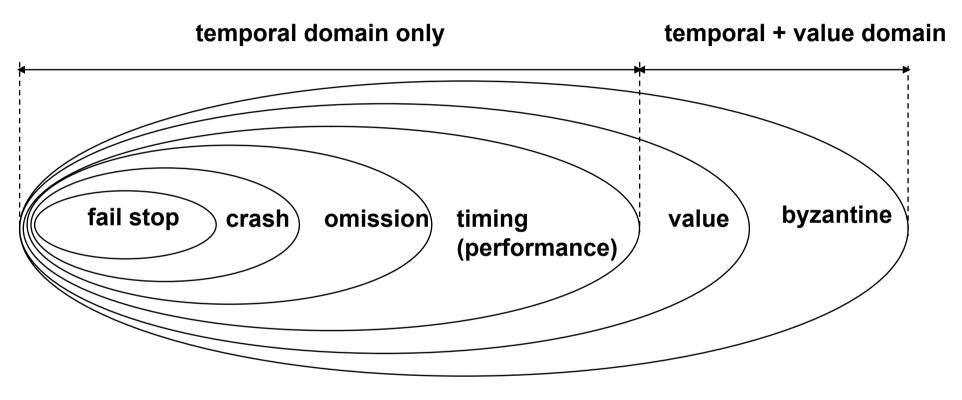
Omission Failures: Special class of timing failures. Correct values are available in time or not at all.

Crash Failures: Component does not deliver any data.

#### Fail Stop:

Failed component stops to produce results. Components are able to diagnose the Crash Failure correctly.

## **Fault Model and Failure Semantics**



masking  $\uparrow$  resend, time-out, duplicate msg. recognition and removal, mapping  $\int$  check sum, replication, majority voting.

## Fault Model and Failure Semantics

Fault Class	affects:	description
fail stop	process	A process crashes and remains inactive. All all participants safely detect this state.
crash	process	A process crashes and remains inactive. Other processes amy not detect this state.
omission	channel	A message in the output message buffer of one process never reaches the input message buffer of the other process.
- send om.	channel	A process completes the send but the respective message is never written in its send output buffer.
- receive om.	channel	A message is written in the input message buffer of a process but never processed.
byzantine	process	An arbitrary behaviour of a process.



**Reliable 1-to-1 Communication:** 

- Validity: every message which is sent (queued in the out-buffer of a correct process) will eventually be received (queued in the in-buffer of an correct process)
- Integrity: the message received is identical with the message sent and no message is delivered more than once.

#### Validity and integrity are properties of a channel!



## Fault Model and Failure Semantics

UDP provides a Channels with Omission Faults and doesn't guarantee any order. TCP provides a Reliable FiFo-Ordered Point-to-Point Connection (Channel)

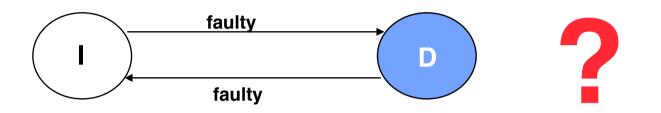
Mechanisms	Effect
sequence numbers assigned to packets	FiFo between sender and receiver. Allows to detect duplicates.
acknowledge of packets	Allows to detect missing packets on the sender side and initiates retransmission
Checksum for data segments	Allows detection of value failures.
Flow Control	Receiver sends expected "window size" characterizing the amount of data for future transmissions together with ack.



# Fault diagnosis in Distributed Systems



## System diagnosis to detect and localize faults



**Assumptions:** 

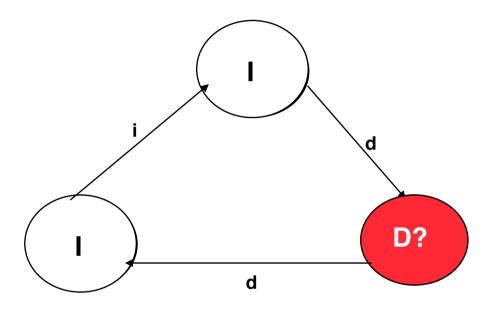
- components are either faulty or correct.
- a test is complete and correct.
- a correct process wil deliver a correct result.
- a faulty process will deliver an arbitrary result.
- a central correct observer evaluates the result of the test.

F. P. Preparata, G. Metze, and R. T. Chien. On the connection assignment problem of diagnosable systems. IEEE Trans. Electron. Comput., EC--16:848--854, 1967



## f – diagnosability

#### 1-diagnosable system



**Assumptions:** 

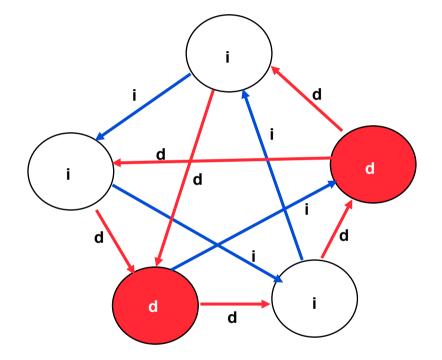
- components are either faulty or correct.
- a test is complete and correct.
- a correct process wil deliver a correct result.
- a faulty process will deliver an arbitrary result.
- a node is marked as faulty if it has an incoming edge originating from a correct node, which has tested this node as faulty
- a central correct observer evaluates the result of the test.

#### f – diagnosable :

A system with n components is f-diagnosable if  $n \ge 2f + 1$  and every component test at least f other components. The components do not test each other.



### 2-diagnosable system

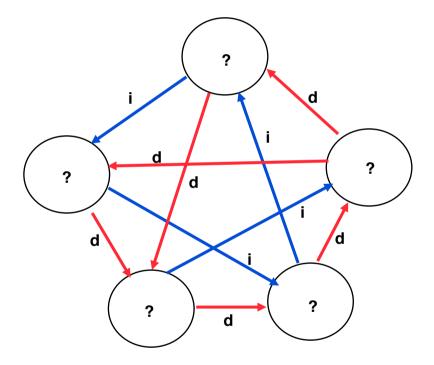


**Assumptions:** 

- components are either faulty or correct.
- a test is complete and correct.
- a correct process wil deliver a correct result.
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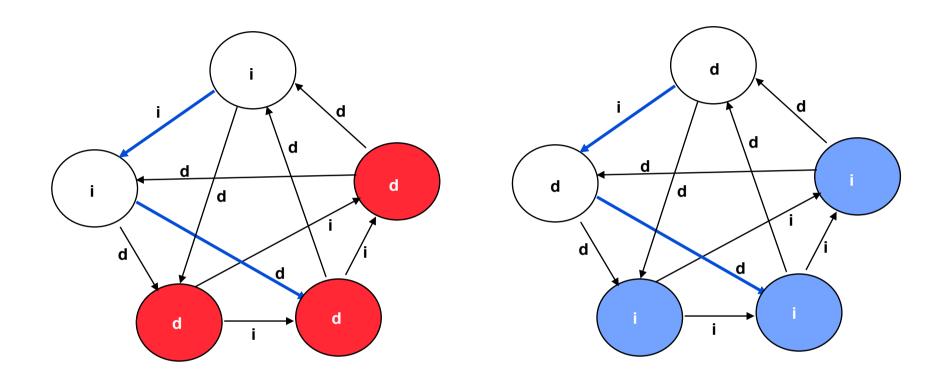


Can diagnosis deliver an unambiguous result?





## **3 faulty nodes**



## fault cannot be detected (obviously) because the fault assumption (max. 2 faults) is violated.



**Assumption:** 

Node is the unit of fault-containment and replacement!

**Problems:** 

1. What kind of faults have to be considered?



Fault model.

2. Can we replace the central evaluation component?



Distributed consensus.

3. Can fault-detection always successfully be performed? The problem of synchrony.



## The Network or the Node?

## Fault-assumptions in Distributed Systems



**Intuitive Consistency Criterion:** 

When a process fails, all correct processes are able to detect the failure and achieve consensus about the faulty process.

Formalisation by Chandra and Tueg (1996):

**Strong Acuracy (SA):** No correct process ever is considered to be faulty. (safety criterion)

**Strong Completeness (SC):** A faulty process eventually will be detected by every correct process (liveness criterion).



What are the conditions to achieve SA and SC?

#### **Assumptions:**

- 1. Transmission delays can be bounded.
- 2. Processes can generate and send a "heartbeat" message periodically in a bounded time interval.
- 3. We assume a crash failure model, i.e. the network is fault-free.

Heartbeat-mechanism is a perfect failure detector

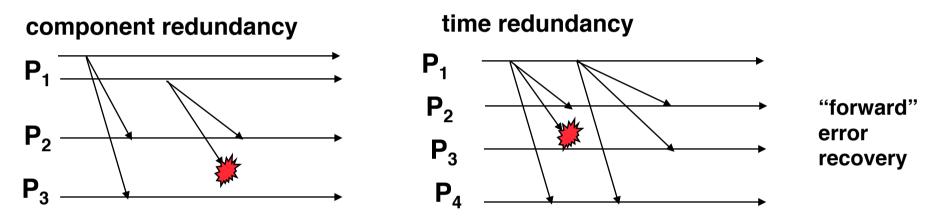
#### **Assumptions:**

- 1. Transmission delays can be bounded.
- 2. Processes can generate and send a "heartbeat" message periodically in a bounded time interval.
- 3. We assume an omission failure model, however the omissions may be bounded.

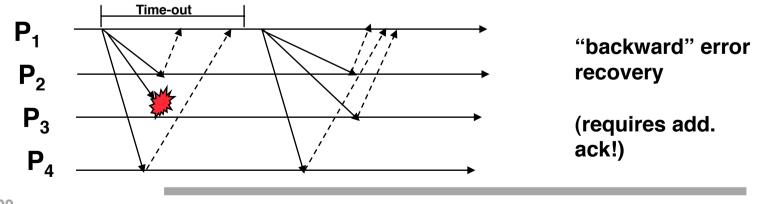




#### **Static Redundancy: Masking Failures**

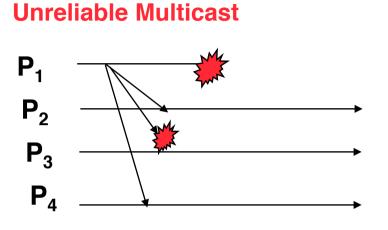


#### **Dynamic Redundancy: Detection + Recovery**

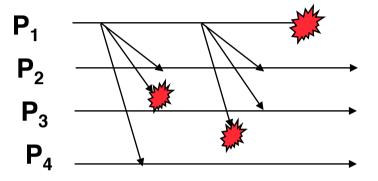




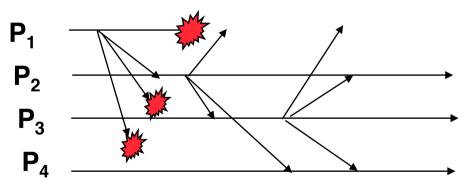
#### FT Communication - Handling *sender* failures



#### **Best effort Multicast**



**Reliable Multicast** 





**Assumptions:** 

Temporal assumptions:

- 1. the latency of messages cannot be bounded,
- 2. processes cannot always produce a heartbeat in a bounded interval.

**Assmptions about the number of faults:** 

3. The number of omissions cannot be bounded.



No deterministic decision can be derived whether a process has failed or not.



Goal: A group of processes agree on a common value. Every process proposes a value once. Every process decide a value once. Proposed and decided values are 0 or 1 (simplification).

The following conditions must be achieved:

Consistency:All processes eventually agree on the same value and<br/>(Agreement)(Agreement)the decision is final.

**Non Triviality:** The decided value has been proposed by some process. (Validity)

**Termination:** Every correct process decides on the common value within a finite time interval.



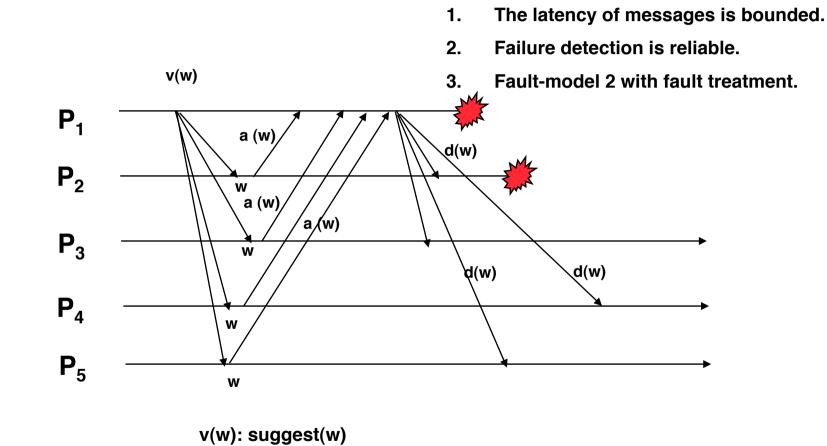
#### **FLP Impossibility Result**

Michael J. Fischer, Nancy A. Lynch, and Michael S. Paterson. Impossibility of distributed consensus with one faulty process. Journal of the ACM, 32(2):374{382, April 1985.



### **Fault-Tolerant Consensus**

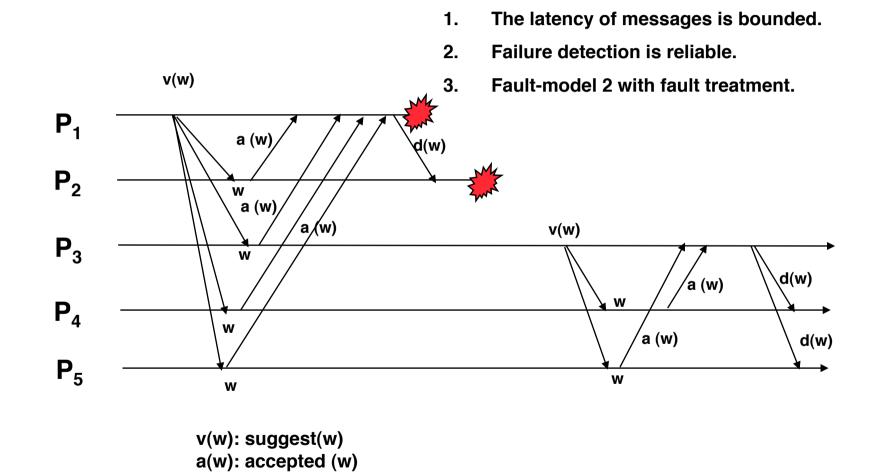
a(w): accepted (w) d(w): decided (w)



#### **Assumptions:**

### **Fault-Tolerant Consensus**

d(w): decided (w)



**Assumptions:** 

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How much redundancy is needed to achieve consensus about the faulty nodes?

The results of Preparata, Metze & Chien say: 2f+1 Evaluation centralized! > No consensus is needed.

Is this majority also enough for distributed consensus? Does the fault model influence the redundancy requirements?

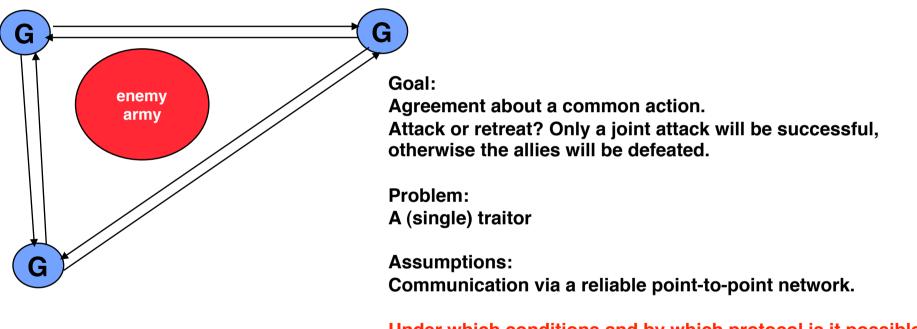




#### **Byzantine Faults and Byzantine Agreement**

L. Lamport, R. Shostak, M. Pease: "The byzantine generals' problem", ACM TC on Progr. Languages and systems, 4(3), 1982

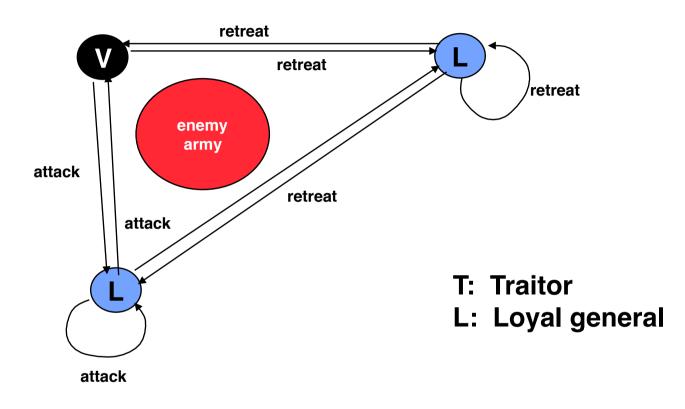
#### The Story:



Under which conditions and by which protocol is it possible to derive a correct majority vote?



#### **Byzantine Faults and Byzantine Agreement**

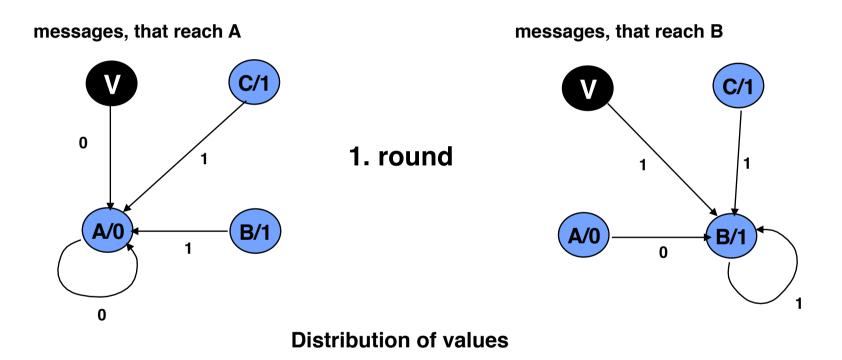


Even multiple rounds will not help to achieve agreement because a loyal general never knows who is the traitor.



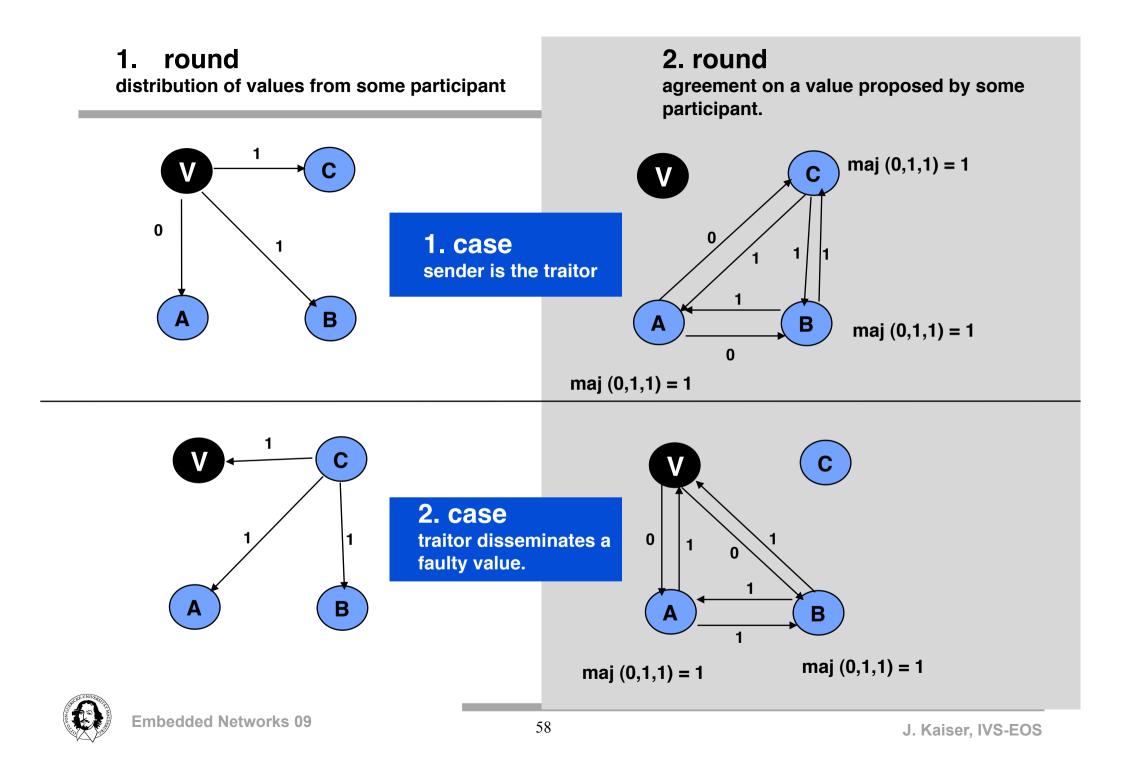
**Byzantine Faults and Byzantine Agreement** 

#### Agreement on a value in two rounds



During the first round no unambiguous decision is possible because A and B don't agree.





- Participants are processes.
- Evenry process locally desides by majority voting on the value that is decided by evera correct process.
- The value decided by the majority of processes is the corect value.
- To detect f byzantine faults,

(3f + 1) processes are needed.

